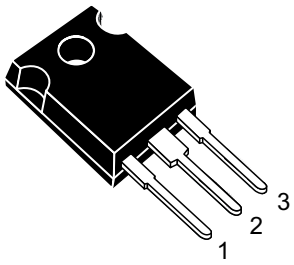
STGW15M120DF3
STGWA15M120DF3

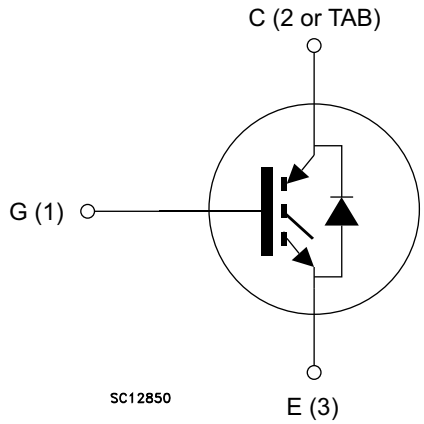
Trench gate field-stop IGBT, M series 1200 V, 15 A low loss

Datasheet - production data



TO-247
TO-247 long leads

Figure 1.Internal schematic diagram



Features

- 10 µs of short-circuit withstand time
- $V_{CE(sat)}$ = 1.85 V (typ.) @ I_C = 15 A
- Tight parameters distribution
- Safer paralleling
- Low thermal resistance
- Soft and fast recovery antiparallel diode

Applications

- Industrial drives
- UPS
- Solar
- Welding

Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series of IGBTs, which represent an optimum compromise in performance to maximize the efficiency of inverter systems where low-loss and short circuit capability are essential. Furthermore, a positive $V_{CE(sat)}$ temperature coefficient and tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

Order code	Marking	Package	Packaging
STGW15M120DF3	G15M120DF3	TO-247	Tube
STGWA15M120DF3	G15M120DF3	TO-247 long leads	Tube

Contents

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage (V_{GE} = 0)	1200	V
I_C	Continuous collector current at T_C = 25 °C	30	A
I_C	Continuous collector current at T_C = 100 °C	15	A
I_{CP}(1)	Pulsed collector current	60	A
V_{GE}	Gate-emitter voltage	±20	V
I_F	Continuous forward current at T_C = 25 °C	30	A
I_F	Continuous forward current at T_C = 100 °C	15	A
I_{FP}(1)	Pulsed forward current	60	A
P_{TOT}	Total dissipation at T_C = 25 °C	259	W
T_{STG}	Storage temperature range	- 55 to 150	°C
T_J	Operating junction temperature	- 55 to 175	°C

1. Pulse width limited by maximum junction temperature.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance junction-case IGBT	0.58	°C/W
R_{thJC}	Thermal resistance junction-case diode	1.3	°C/W
R_{thJA}	Thermal resistance junction-ambient	50	°C/W

2 Electrical characteristics

T_J = 25 °C unless otherwise specified.

Table 4. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage (V_{GE} = 0)	I_C = 2 mA	1200			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	V_{GE} = 15 V, I_C = 15 A		1.85	2.3	V
		V_{GE} = 15 V, I_C = 15 A, T_J = 125 °C		2.1		
		V_{GE} = 15 V, I_C = 15 A T_J = 175 °C		2.2		
V_F	Forward on-voltage	I_F = 15 A		2.7	3.8	V
		I_F = 15 A T_J = 125 °C		2.05		V
		I_F = 15 A T_J = 175 °C		1.75		V
$V_{GE(th)}$	Gate threshold voltage	V_{CE} = V_{GE}, I_C = 500 µA	5	6	7	V
I_{CES}	Collector cut-off current (V_{GE} = 0)	V_{CE} = 1200 V			25	µA
I_{GES}	Gate-emitter leakage current (V_{CE} = 0)	V_{GE} = ± 20 V			250	nA

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	V_{CE} = 25 V, f = 1 MHz, V_{GE} = 0	-	985	-	pF
C_{oes}	Output capacitance		-	118	-	pF
C_{res}	Reverse transfer capacitance		-	38	-	pF
Q_g	Total gate charge	V_{CC} = 960 V, I_C =15 A, V_{GE} = 15 V, see *Figure 30*	-	53	-	nC
Q_{ge}	Gate-emitter charge		-	8	-	nC
Q_{gc}	Gate-collector charge		-	32	-	nC

Table 6. IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	V_{CE} = 600 V, I_C = 15 A, V_{GE} = 15 V, R_G= 22 Ω see Figure 29	-	26	-	ns
t_r	Current rise time		-	12	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	1000	-	A/µs
$t_{d(off)}$	Turn-off delay time		-	122	-	ns
t_f	Current fall time		-	163	-	ns
E_{on}(1)	Turn-on switching losses		-	0.55	-	mJ
E_{off}(2)	Turn-off switching losses		-	0.85	-	mJ
E_{ts}	Total switching losses		-	1.4	-	mJ
$t_{d(on)}$	Turn-on delay time	V_{CE} = 600 V, I_C = 15 A, R_G= 22 Ω, V_{GE} = 15 V, T_J = 175 °C, see Figure 29	-	25	-	ns
t_r	Current rise time		-	14	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	857	-	A/µs
$t_{d(off)}$	Turn-off delay time		-	136	-	ns
t_f	Current fall time		-	270	-	ns
E_{on}(1)	Turn-on switching losses		-	1.1	-	mJ
E_{off}(2)	Turn-off switching losses		-	1.13	-	mJ
E_{ts}	Total switching losses		-	2.23	-	mJ
t_{sc}	Short-circuit withstand time	V_{CC} ≤ 600V, V_{GE}= 15V, T_{Jstart}= 150°C	10		-	µs

1. Energy losses include reverse recovery of the diode.
2. Turn-off losses include also the tail of the collector current.

Table 7. Diode switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{rr}	Reverse recovery time	I_F = 15 A, V_R = 600 V, V_{GE} = 15 V, see Figure 29 di/dt = 1000 A/µs	-	270	-	ns
Q_{rr}	Reverse recovery charge		-	0.96	-	µC
I_{rrm}	Reverse recovery current		-	15	-	A
dI_{rr}/dt	Peak rate of fall of reverse recovery current during t_b		-	935	-	A/µs
E_{rr}	Reverse recovery energy		-	0.18	-	mJ
t_{rr}	Reverse recovery time	I_F = 15 A, V_R = 600 V, V_{GE} = 15 V, T_J = 175 °C, see Figure 29 di/dt = 1000 A/µs	-	534	-	ns
Q_{rr}	Reverse recovery charge		-	3.45	-	µC
I_{rrm}	Reverse recovery current		-	23	-	A
dI_{rr}/dt	Peak rate of fall of reverse recovery current during t_b		-	266	-	A/µs
E_{rr}	Reverse recovery energy		-	0.55	-	mJ

2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

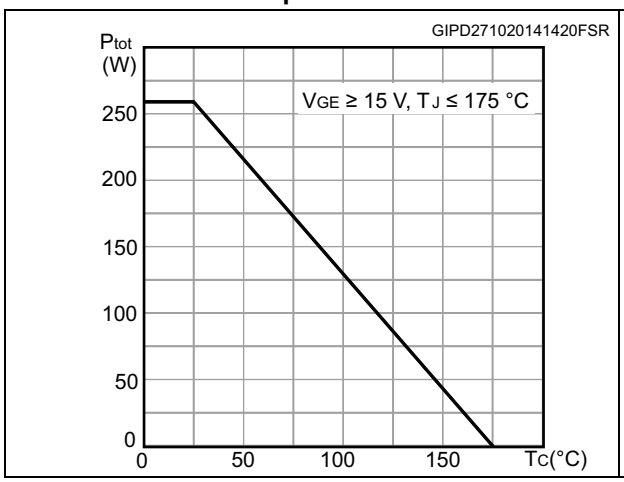


Figure 3. Collector current vs. case temperature

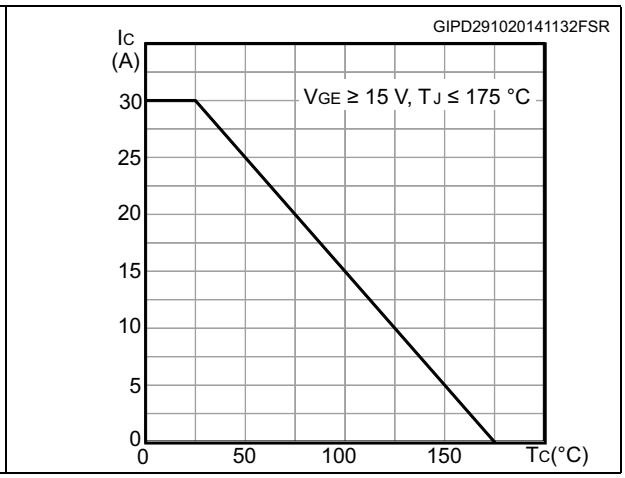


Figure 4. Output characteristics (T_J=25°C)

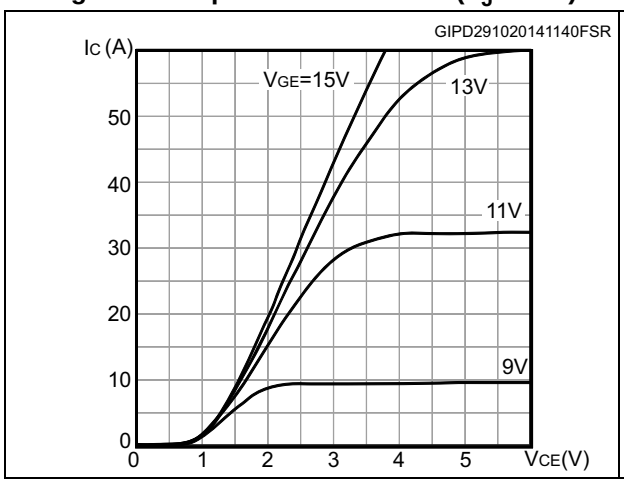


Figure 5. Output characteristics (T_J=175°C)

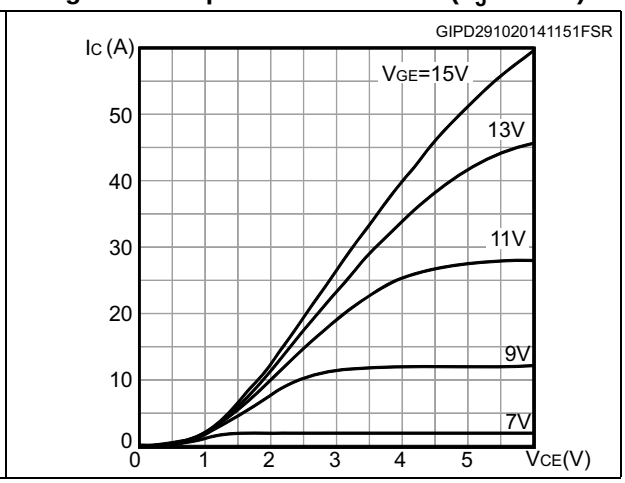


Figure 6. $V_{CE(sat)}$ vs. junction temperature

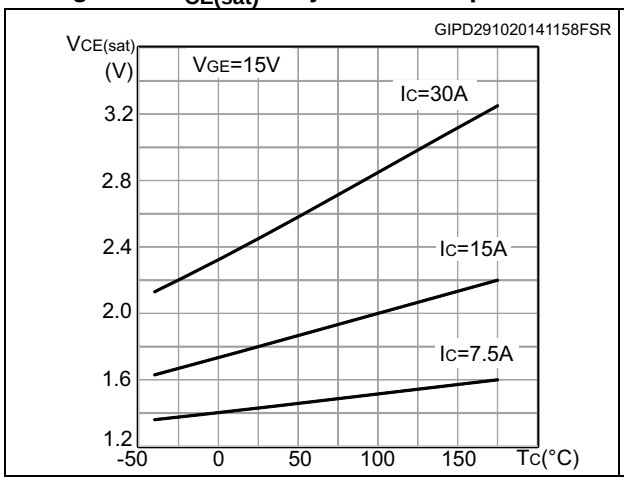


Figure 7. $V_{CE(sat)}$ vs. collector current

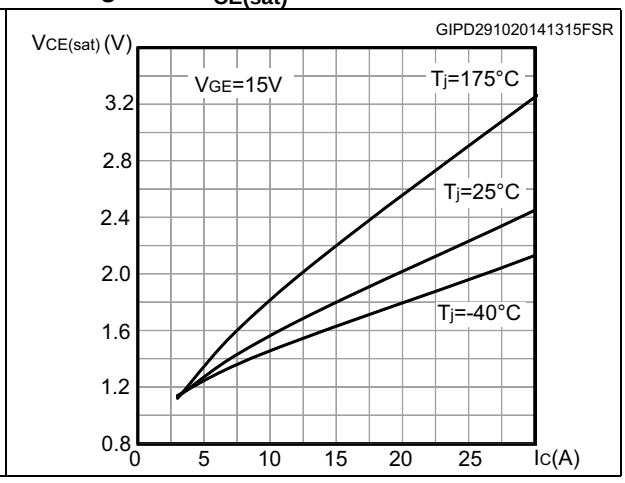


Figure 8. Collector current vs. switching frequency

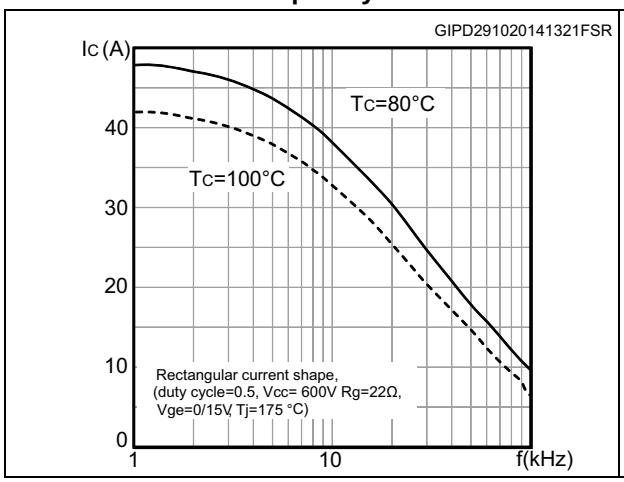


Figure 9. Safe operating area

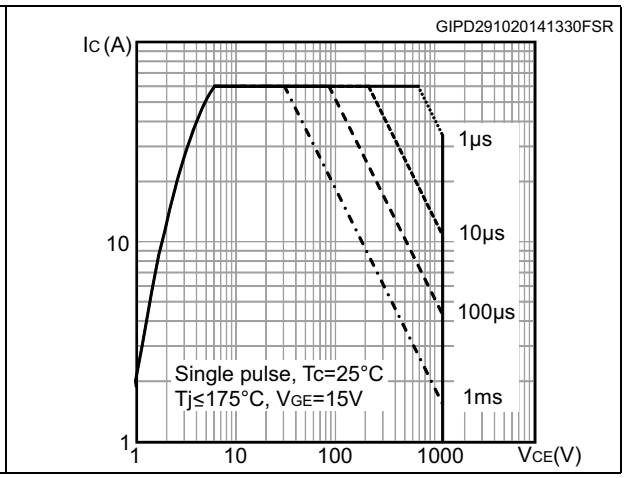


Figure 10. Transfer characteristics

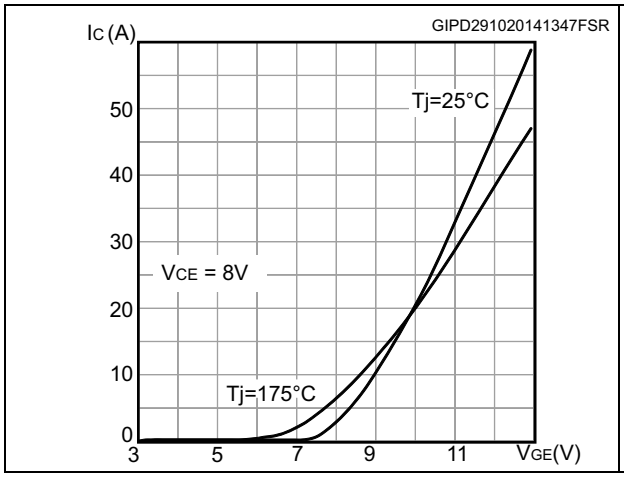


Figure 11. Diode V_F vs forward current

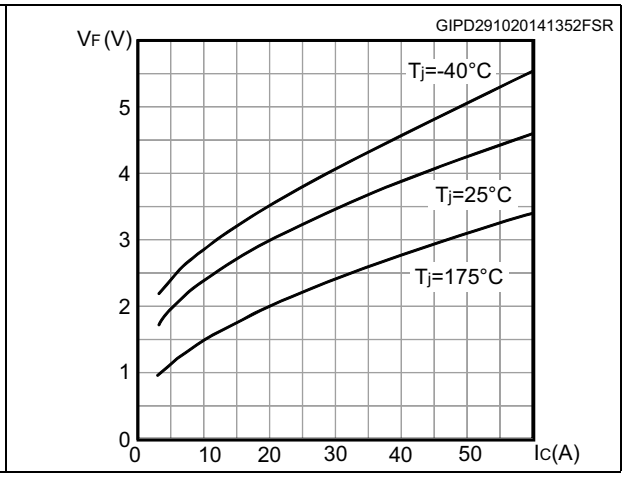


Figure 12. Normalized $V_{GE(th)}$ vs junction temperature

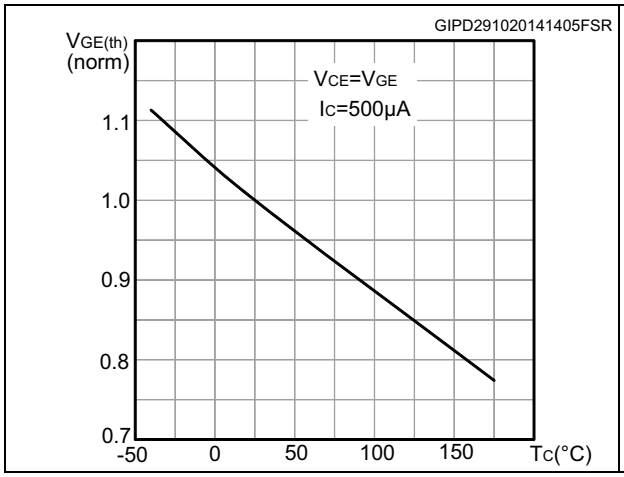


Figure 13. Normalized $V_{(BR)CES}$ vs. junction temperature

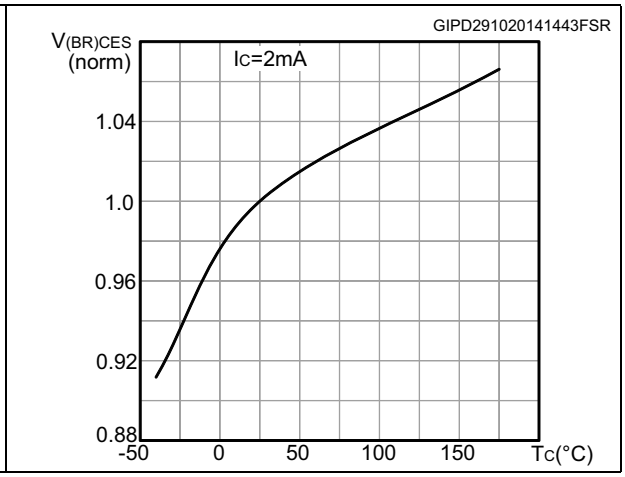


Figure 14. Capacitance variations

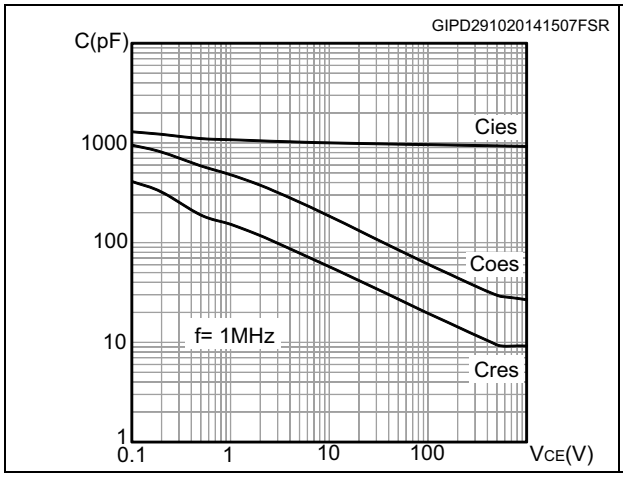


Figure 15. Gate charge vs. gate-emitter voltage

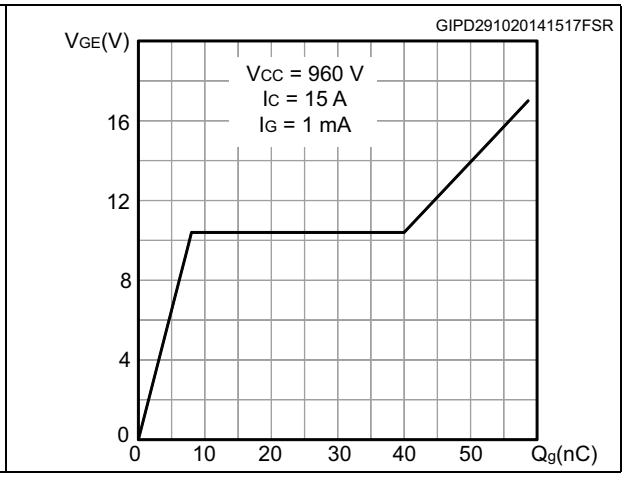


Figure 16. Switching loss vs. collector current

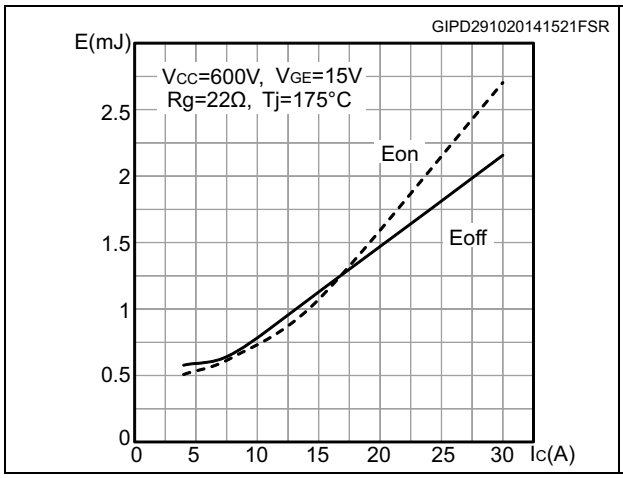


Figure 17. Switching loss vs. gate resistance

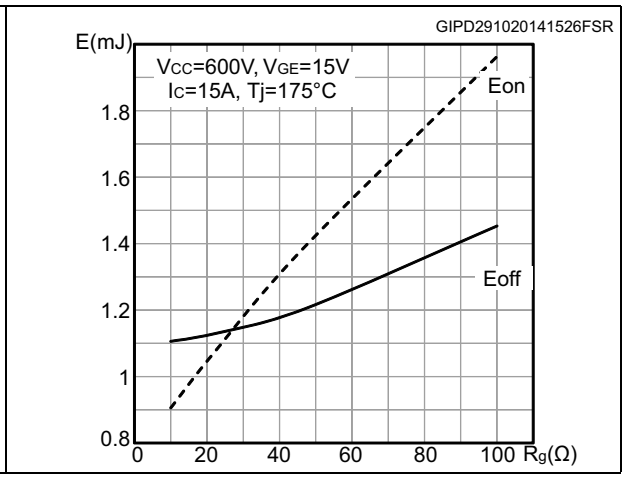


Figure 18. Switching loss vs. junction temperature

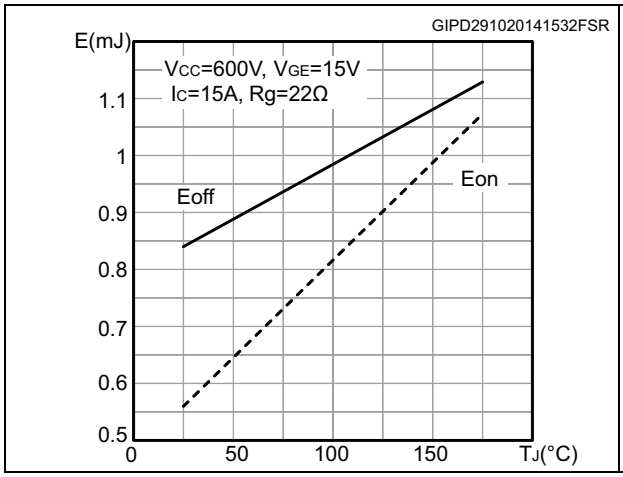


Figure 19. Switching loss vs. collector emitter voltage

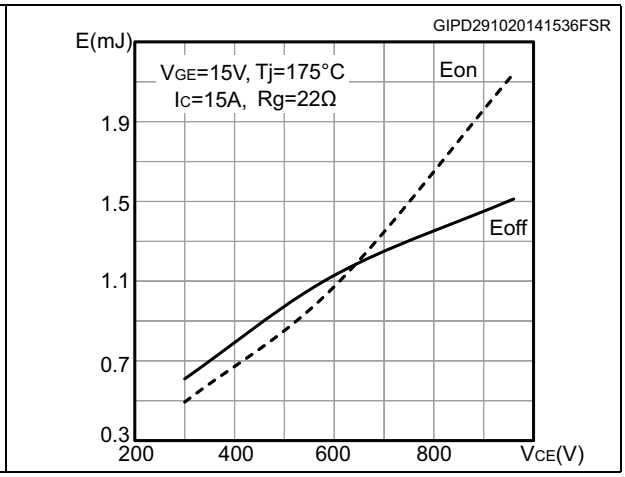


Figure 20. Short-circuit time and current vs. V_{GE}

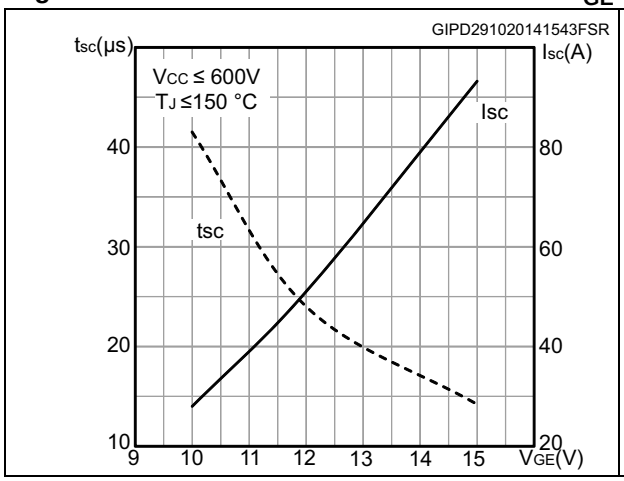


Figure 21. Switching times vs. collector current

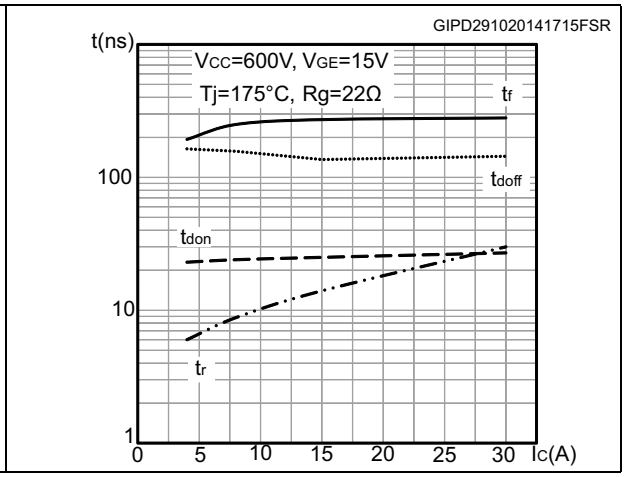


Figure 22. Switching times vs. gate resistance

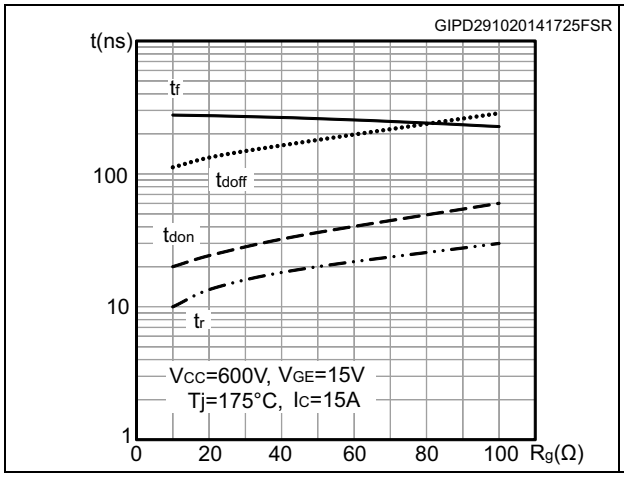


Figure 23.Reverse recovery current vs. diode current slope

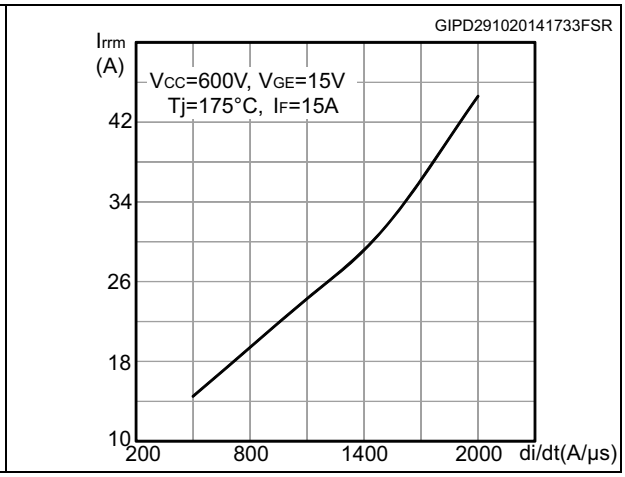


Figure 24. Reverse recovery time vs. diode current slope

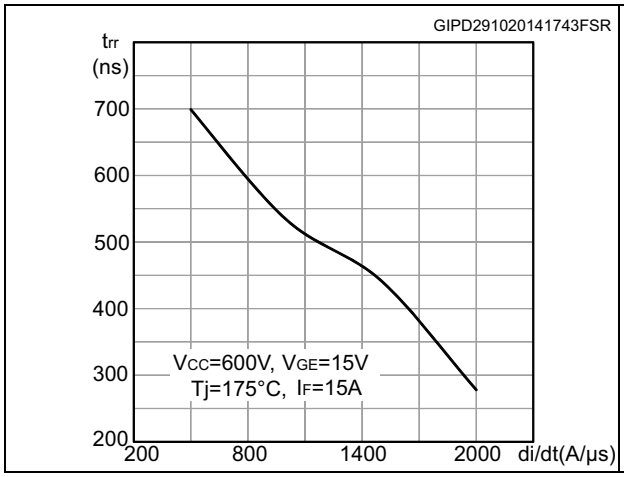


Figure 25.Reverse recovery charge vs. diode current slope

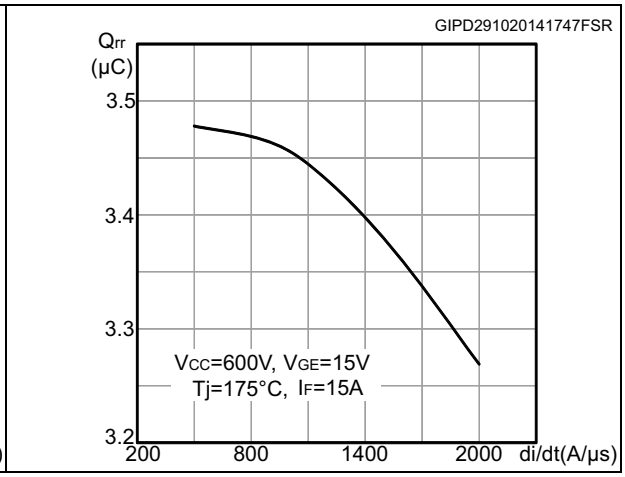


Figure 26. Reverse recovery energy vs. diode current slope

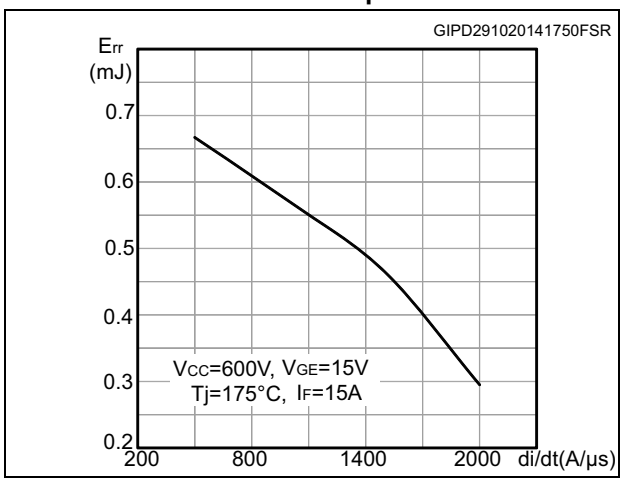


Figure 27.Thermal impedance for IGBT

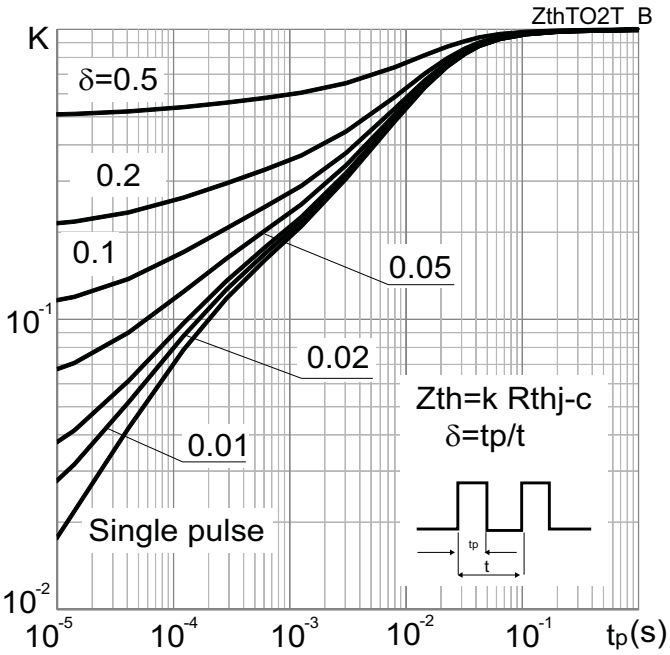
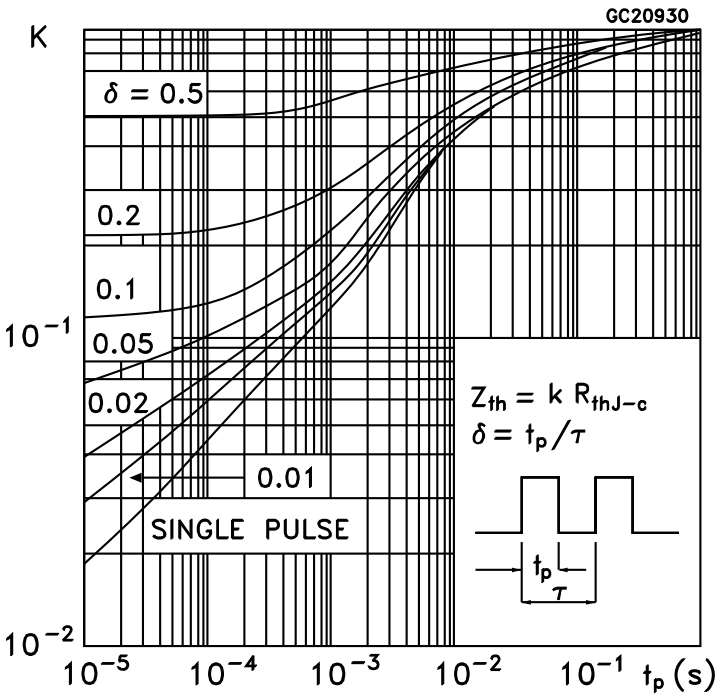


Figure 28.Thermal impedance for diode



3 Test circuits

Figure 29. Test circuit for inductive load switching

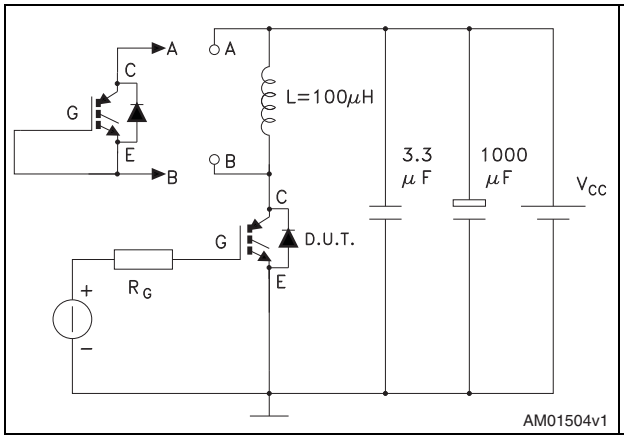


Figure 30. Gate charge test

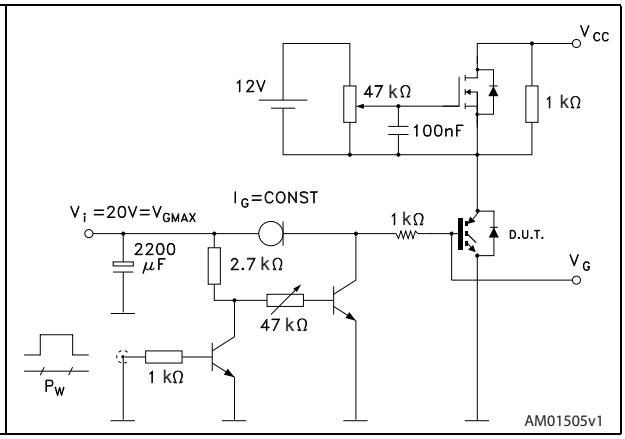


Figure 31. Switching waveform

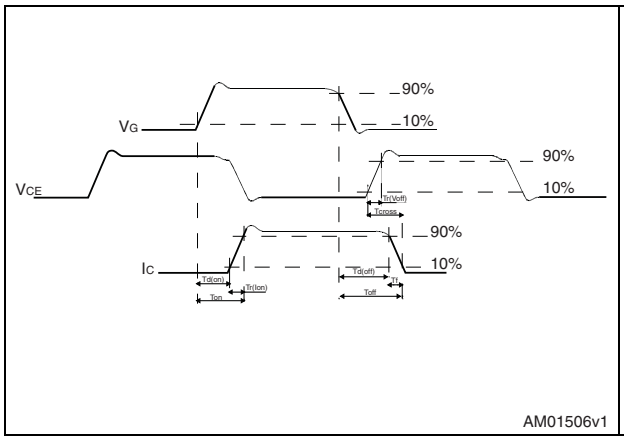
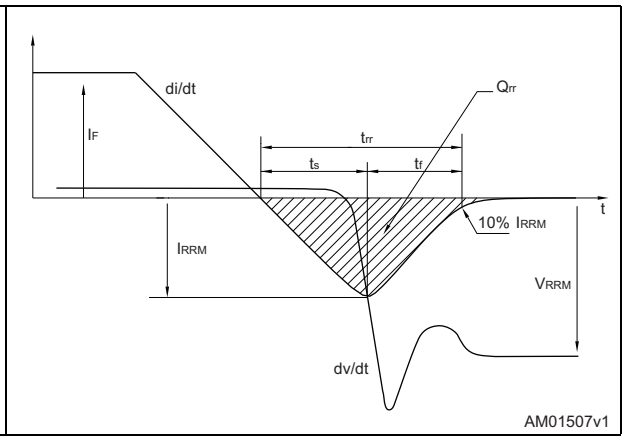


Figure 32. Diode reverse recovery waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO-247, STGW15M120DF3

Figure 33. TO-247 drawing

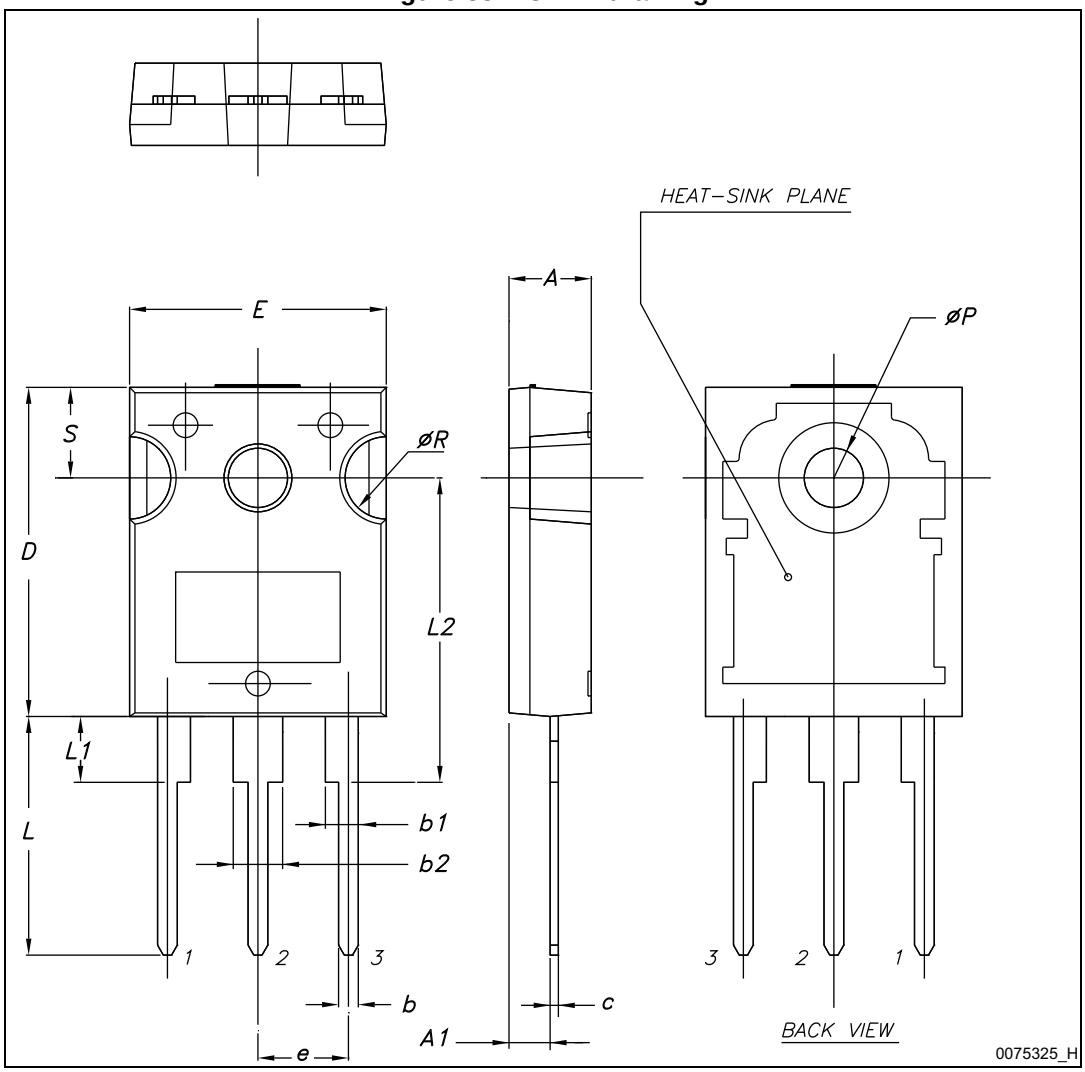


Table 8. TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
∅P	3.55		3.65
∅R	4.50		5.50
S	5.30	5.50	5.70

4.2 TO-247 long leads, STGWA15M120DF3

Figure 34. TO-247 long leads drawing

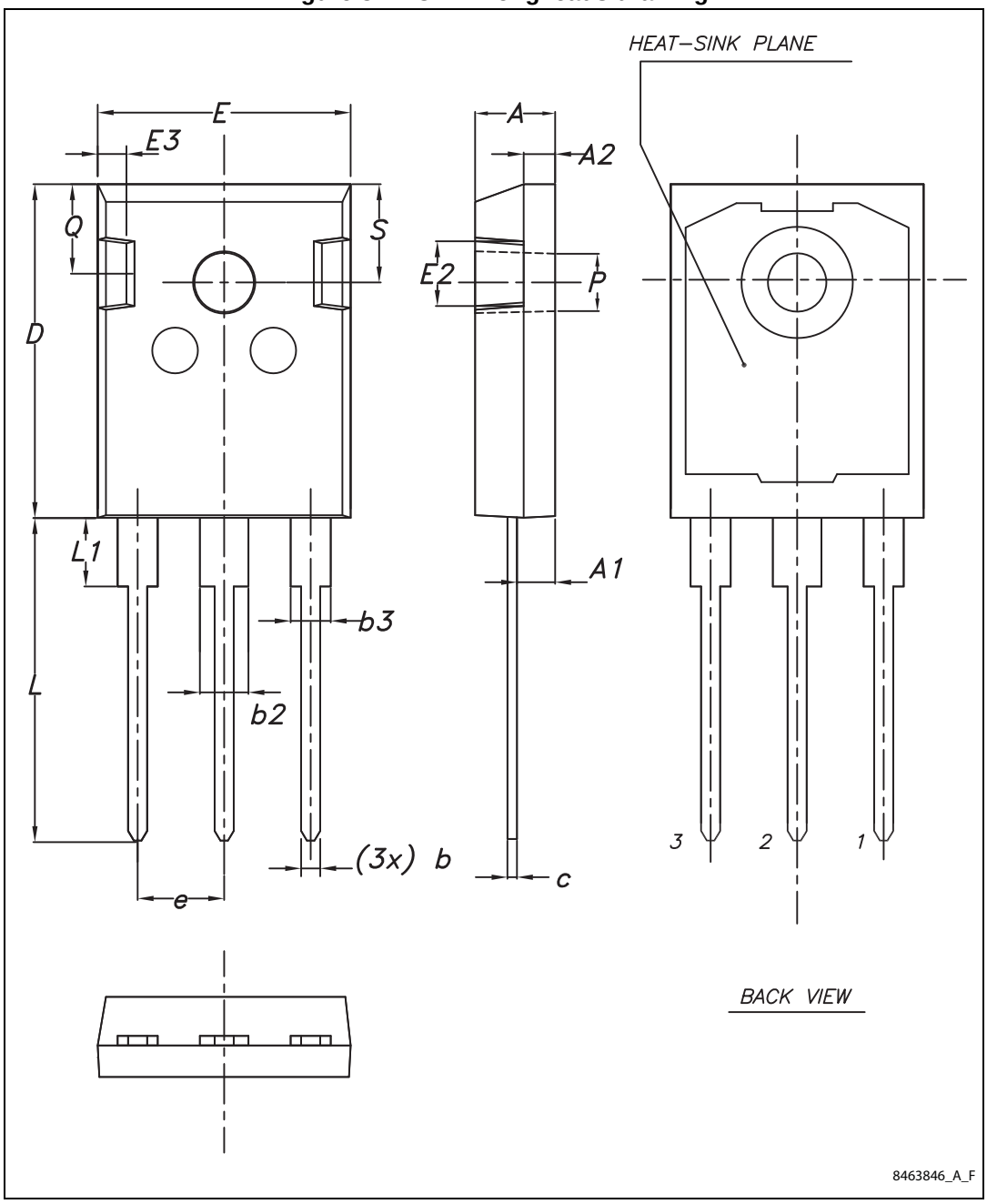


Table 9. TO-247 long leads mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
c	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
P	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
22-Apr-2014	1	Initial release.
31-Oct-2014	2	Document status promoted from preliminary to production data. Updated all the document accordingly. Added *Section 2.1: Electrical characteristics (curves)*. Updated *Section 4: Package mechanical data*.

Стандарт Электрон Связь

Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

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